

# 50-MHz TO 6-GHz QUADRATURE MODULATOR

Check for Samples: TRF370417

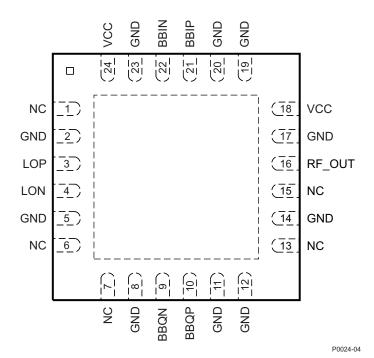
#### **FEATURES**

- 76-dBc Single-Carrier WCDMA ACPR at –8 dBm Channel Power
- Low Noise Floor: –162.3 dBm/Hz at 2140 MHz
- OIP3 of 26.5 dBm at 2140 MHz
- P1dB of 12 dBm at 2140 MHz
- Carrier Feedthrough of -38 dBm at 2140 MHz
- Side-Band Suppression of –50 dBc at 2140 MHz
- Single Supply: 4.5-V-5.5-V Operation
- Silicon Germanium Technology
- 1.7-V CM at I, Q Baseband Inputs

#### **APPLICATIONS**

- Cellular Base Station Transceiver
- CDMA: IS95, UMTS, CDMA2000, TD-SCDMA
- TDMA: GSM, IS-136, EDGE/UWC-136
- Multicarrier GSM
- WiMAX: 802.16d/e
- 3GPP: LTE
- Point-to-Point (P2P) Microwave
- Wideband Software-Defined Radio
- Public Safety: TETRA/APC025
- Communication-System Testers
- Cable Modem Termination System (CMTS)

#### RGE PACKAGE (TOP VIEW)



#### DESCRIPTION

The TRF370417 is a low-noise direct quadrature modulator, capable of converting complex modulated signals from baseband or IF directly up to RF. The TRF370417 is a high-performance, superior-linearity device that operates at RF frequencies of 50 MHz through 6 GHz. The modulator is implemented as a double-balanced mixer. The RF output block consists of a differential to single-ended converter and an RF amplifier capable of driving a single-ended 50-Ω load without any need of external components. The TRF370417 requires a 1.7-V common-mode voltage for optimum linearity performance.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

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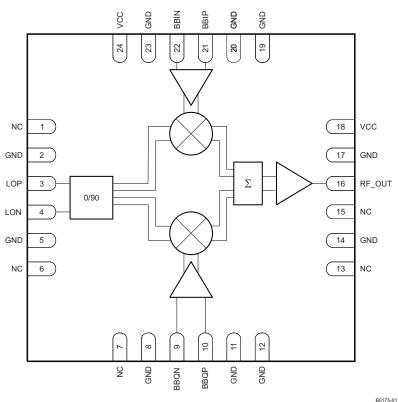




This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

#### **Functional Block Diagram**



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NOTE: NC = No connection

# DEVICE INFORMATION

#### **TERMINAL FUNCTIONS**

TERMINAL		1/0	DECORPTION			
NAME	NO.	I/O	DESCRIPTION			
BBIN	22	I	In-phase negative input			
BBIP	21	I	In-phase positive input			
BBQN	9	I	Quadrature-phase negative input			
BBQP	10	I	Quadrature-phase positive input			
GND	2, 5, 8, 11, 12, 14, 17, 19, 20, 23	_	Ground			
LON	4	I	Local oscillator negative input			
LOP	3	I	Local oscillator positive input			
NC	1, 6, 7, 13, 15	-	No connect			
RF_OUT	16	0	RF output			
VCC	18, 24	_	Power supply			

### ABSOLUTE MAXIMUM RATINGS(1)

over operating free-air temperature range (unless otherwise noted)

		VALUE <sup>(2)</sup>	UNIT
	Supply voltage range	−0.3 V to 6	V
$T_{J}$	Operating virtual junction temperature range	-40 to 150	°C
T <sub>A</sub>	Operating ambient temperature range	-40 to 85	°C
T <sub>stg</sub>	Storage temperature range	-65 to 150	°C
ESD Rating	НВМ	75	V
ESD Rating	CDM	75	V

<sup>(1)</sup> Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

#### **RECOMMENDED OPERATING CONDITIONS**

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
$V_{CC}$	Power-supply voltage	4.5	5	5.5	V

#### THERMAL CHARACTERISTICS

	PARAMETER	TEST CONDITIONS	VALUE	UNIT
$R_{\theta JA}$	Thermal resistance, junction-to-ambient	High-K board, still air	29.4	°C/W
$R_{\theta JC}$	Thermal resistance, junction-to-case		18.6	°C/W
$R_{\theta JB}$	Thermal resistance, junction-to-board		14	°C/W

#### **ELECTRICAL CHARACTERISTICS**

over operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
DC Para	ameters		·		Ÿ	
Icc	Total supply current (1.7 V CM)	Total supply current (1.7 V CM) T <sub>A</sub> = 25°C				
LO Inpu	ıt (50-Ω, Single-Ended)					
	LO frequency range		0.05		6	GHz
$f_{LO}$	LO input power		-5	0	12	dBm
	LO port return loss			15		dB
Baseba	nd Inputs		•			
$V_{CM}$	I and Q input dc common voltage			1.7		
BW	1-dB input frequency bandwidth			1		GHz
7	Input impedance, resistance			5		kΩ
Z <sub>I(single</sub> ended)	Input impedance, parallel capacitance			3		pF

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<sup>(2)</sup> All voltage values are with respect to network ground terminal.

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#### **RF OUTPUT PARAMETERS**

over recommended operating conditions, power supply = 5 V,  $T_A = 25$ °C,  $V_{CM} = 1.7$  V,  $V_{inBB} = 98$  mVrms single-ended in quadrature,  $f_{BB} = 50$  kHz (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN TYP	MAX UN	lIТ
f <sub>LO</sub> = 7	0 MHz at 8 dBm			1	
G	Voltage gain	Output rms voltage over input I (or Q) rms voltage	-8	dE	В
P1dB	Output compression point		7.3	dB	lm
IP3	Output IP3	f <sub>BB</sub> = 4.5, 5.5 MHz; P <sub>out</sub> = -8 dBm per tone	22	dB	3m
IP2	Output IP2	f <sub>BB</sub> = 4.5, 5.5 MHz; P <sub>out</sub> = -8 dBm per tone	69	dB	3m
	Carrier feedthrough	Unadjusted	-46	dB	3m
	Sideband suppression	Unadjusted; f <sub>BB</sub> = 4.5, 5.5 MHz	-27.5	dB	3c
f <sub>LO</sub> = 4	00 MHz at 8 dBm				
G	Voltage gain	Output rms voltage over input I (or Q) rms voltage	-1.9	dE	В
P1dB	Output compression point		11	dB	3m
IP3	Output IP3	$f_{BB} = 4.5, 5.5 \text{ MHz}; P_{out} = -8 \text{ dBm per tone}$	24.5	dB	3m
IP2	Output IP2	$f_{BB} = 4.5, 5.5 \text{ MHz}; P_{out} = -8 \text{ dBm per tone}$	68	dB	lm
	Carrier feedthrough	Unadjusted	-38	dB	3m
	Sideband suppression	Unadjusted; f <sub>BB</sub> = 4.5, 5.5 MHz	-40	dB	3c
f <sub>LO</sub> = 9	45.6 MHz at 8 dBm				
G	Voltage gain	Output rms voltage over input I (or Q) rms voltage	-2.5	dE	В
P1dB	Output compression point		11	dB	3m
IP3	Output IP3	f <sub>BB</sub> = 4.5, 5.5 MHz; P <sub>out</sub> = -8 dBm per tone	25	dB	3m
IP2	Output IP2	f <sub>BB</sub> = 4.5, 5.5 MHz; P <sub>out</sub> = -8 dBm per tone	65	dB	3m
	Carrier feedthrough	Unadjusted	-40	dB	3m
	Sideband suppression	Unadjusted; f <sub>BB</sub> = 4.5, 5.5 MHz	-42	dB	3c
	Output return loss		9	dE	В
	Output noise floor	≥13 MHz offset from f <sub>LO</sub> ; P <sub>out</sub> = −5 dBm	-161.2	dBm	ı/Hz
f <sub>LO</sub> = 1	800 MHz at 8 dBm			•	
G	Voltage gain	Output rms voltage over input I (or Q) rms voltage	-2.5	dE	В
P1dB	Output compression point		12	dB	3m
IP3	Output IP3	$f_{BB} = 4.5, 5.5 \text{ MHz}; P_{out} = -8 \text{ dBm per tone}$	26	dB	3m
IP2	Output IP2	$f_{BB} = 4.5, 5.5 \text{ MHz}; P_{out} = -8 \text{ dBm per tone}$	60		3m
	Carrier feedthrough	Unadjusted	-40	dB	3m
	Sideband suppression	Unadjusted; f <sub>BB</sub> = 4.5, 5.5 MHz	-50		Зс
	Output return loss		8	dE	В
	Output noise floor	≥13 MHz offset from f <sub>LO</sub> ; P <sub>out</sub> = −5 dBm	-161.5	dBm	ı/Hz

#### **RF OUTPUT PARAMETERS (continued)**

over recommended operating conditions, power supply = 5 V,  $T_A = 25$ °C,  $V_{CM} = 1.7$  V,  $V_{inBB} = 98$  mVrms single-ended in quadrature,  $f_{BB} = 50$  kHz (unless otherwise noted)

G Volume 1	O MHz at 8 dBm  Voltage gain Output compression point Output IP3 Output IP2 Carrier feedthrough Sideband suppression Output return loss Output noise floor Error vector magnitude (rms)	Output rms voltage over input I (or Q) rms voltage $f_{BB} = 4.5, 5.5 \text{ MHz}; P_{out} = -8 \text{ dBm per tone}$ $f_{BB} = 4.5, 5.5 \text{ MHz}; P_{out} = -8 \text{ dBm per tone}$ Unadjusted  Unadjusted; $f_{BB} = 4.5, 5.5 \text{ MHz}$ $\geq 13 \text{ MHz offset from } f_{LO}; P_{out} = -5 \text{ dBm}$ $1 \text{ EDGE signal, } P_{out} = -5 \text{ dBm}^{(1)}$ $1 \text{ WCDMA signal; } P_{out} = -8 \text{ dBm}^{(2)}$ $1 \text{ WCDMA signal; } P_{out} = -8 \text{ dBm}^{(3)}$	-2.5 12 26.5 60 -38 -50 8 -162 0.43% -76		dB dBm dBm dBm dBm dBc dB dBm/Hz	
P1dB O IP3 O IP2 O C Si O EVM E	Output compression point Output IP3 Output IP2 Carrier feedthrough Sideband suppression Output return loss Output noise floor Error vector magnitude (rms)	$f_{BB} = 4.5, 5.5 \text{ MHz}; P_{out} = -8 \text{ dBm per tone}$ $f_{BB} = 4.5, 5.5 \text{ MHz}; P_{out} = -8 \text{ dBm per tone}$ Unadjusted $Unadjusted; f_{BB} = 4.5, 5.5 \text{ MHz}$ $\geq 13 \text{ MHz offset from } f_{LO}; P_{out} = -5 \text{ dBm}$ $1 \text{ EDGE signal, } P_{out} = -5 \text{ dBm}^{(1)}$ $1 \text{ WCDMA signal; } P_{out} = -8 \text{ dBm}^{(2)}$	12 26.5 60 -38 -50 8 -162 0.43% -76		dBm dBm dBm dBm dBc dB	
IP3 O IP2 O C Si O EVM E	Output IP3 Output IP2 Carrier feedthrough Sideband suppression Output return loss Output noise floor Error vector magnitude (rms)	$f_{BB}$ = 4.5, 5.5 MHz; $P_{out}$ = −8 dBm per tone  Unadjusted  Unadjusted; $f_{BB}$ = 4.5, 5.5 MHz  ≥13 MHz offset from $f_{LO}$ ; $P_{out}$ = −5 dBm  1 EDGE signal, $P_{out}$ = −5 dBm <sup>(1)</sup> 1 WCDMA signal; $P_{out}$ = −8 dBm <sup>(2)</sup>	26.5 60 -38 -50 8 -162 0.43% -76		dBm dBm dBm dBc dB	
IP2 O C Si O O EVM E	Output IP2 Carrier feedthrough Gideband suppression Output return loss Output noise floor Error vector magnitude (rms)	$f_{BB}$ = 4.5, 5.5 MHz; $P_{out}$ = −8 dBm per tone  Unadjusted  Unadjusted; $f_{BB}$ = 4.5, 5.5 MHz  ≥13 MHz offset from $f_{LO}$ ; $P_{out}$ = −5 dBm  1 EDGE signal, $P_{out}$ = −5 dBm <sup>(1)</sup> 1 WCDMA signal; $P_{out}$ = −8 dBm <sup>(2)</sup>	60 -38 -50 8 -162 0.43% -76		dBm dBm dBc dB	
C Si O O EVM E	Carrier feedthrough Sideband suppression Output return loss Output noise floor Error vector magnitude (rms)	Unadjusted  Unadjusted; f <sub>BB</sub> = 4.5, 5.5 MHz  ≥13 MHz offset from f <sub>LO</sub> ; P <sub>out</sub> = -5 dBm  1 EDGE signal, P <sub>out</sub> = -5 dBm <sup>(1)</sup> 1 WCDMA signal; P <sub>out</sub> = -8 dBm <sup>(2)</sup>	-38 -50 8 -162 0.43% -76		dBm dBc dB	
Si O O EVM E	Sideband suppression Output return loss Output noise floor Error vector magnitude (rms)	Unadjusted; f <sub>BB</sub> = 4.5, 5.5 MHz  ≥13 MHz offset from f <sub>LO</sub> ; P <sub>out</sub> = -5 dBm  1 EDGE signal, P <sub>out</sub> = -5 dBm <sup>(1)</sup> 1 WCDMA signal; P <sub>out</sub> = -8 dBm <sup>(2)</sup>	-50 8 -162 0.43% -76		dBc dB	
O O EVM E	Output return loss Output noise floor Error vector magnitude (rms)	≥13 MHz offset from f <sub>LO</sub> ; P <sub>out</sub> = -5 dBm  1 EDGE signal, P <sub>out</sub> = -5 dBm <sup>(1)</sup> 1 WCDMA signal; P <sub>out</sub> = -8 dBm <sup>(2)</sup>	8 -162 0.43% -76		dB	
EVM E	Output noise floor  Error vector magnitude (rms)	1 EDGE signal, P <sub>out</sub> = -5 dBm <sup>(1)</sup> 1 WCDMA signal; P <sub>out</sub> = -8 dBm <sup>(2)</sup>	-162 0.43% -76			
EVM E	error vector magnitude (rms)	1 EDGE signal, P <sub>out</sub> = -5 dBm <sup>(1)</sup> 1 WCDMA signal; P <sub>out</sub> = -8 dBm <sup>(2)</sup>	0.43% -76		dBm/Hz	
	J , ,	1 WCDMA signal; P <sub>out</sub> = -8 dBm <sup>(2)</sup>	-76			
A	djacent-channel power ratio	2 111				
A	djacent-channel power ratio	1 WCDMA signal; P <sub>out</sub> = -8 dBm <sup>(3)</sup>				
A	adjacent-channel power ratio		-74			
		2 WCDMA signals; P <sub>out</sub> = -11 dBm per carrier <sup>(3)</sup>	-68		dBc	
		4 WCDMA signals; P <sub>out</sub> = -14 dBm per carrier <sup>(3)</sup>	-67			
ACPR		1 WCDMA signal; P <sub>out</sub> = -8 dBm <sup>(2)</sup>	-80		dBc	
		1 WCDMA signal; P <sub>out</sub> = -8 dBm <sup>(3)</sup>	-78			
A	Alternate-channel power ratio	2 WCDMA signals; P <sub>out</sub> = -11 dBm per carrier <sup>(3)</sup>	-72			
		4 WCDMA signals; P <sub>out</sub> = -14 dBm per carrier <sup>(3)</sup>	-69			
f <sub>LO</sub> = 2140	0 MHz at 8 dBm			· ·		
G V	oltage gain	Output rms voltage over input I (or Q) rms voltage	-2.4		dB	
P1dB O	Output compression point		12		dBm	
IP3 O	Output IP3	f <sub>BB</sub> = 4.5, 5.5 MHz; P <sub>out</sub> = -8 dBm per tone	26.5		dBm	
IP2 O	Output IP2	$f_{BB} = 4.5, 5.5 \text{ MHz}; P_{out} = -8 \text{ dBm per tone}$	66		dBm	
C	Carrier feedthrough	Unadjusted	-38		dBm	
Si	Sideband suppression	Unadjusted; f <sub>BB</sub> = 4.5, 5.5 MHz	-50		dBc	
0	Output return loss		8.5		dB	
0	Output noise floor	≥13 MHz offset from f <sub>LO</sub> ; P <sub>out</sub> = −5 dBm	-162.3		dBm/Hz	
		1 WCDMA signal; P <sub>out</sub> = -8 dBm <sup>(2)</sup>	-76			
		1 WCDMA signal; P <sub>out</sub> = -8 dBm <sup>(3)</sup>	-72		15	
A	Adjacent-channel power ratio	2 WCDMA signal; P <sub>out</sub> = -11 dBm per carrier <sup>(3)</sup>	-67		dBc	
4000		4 WCDMA signals; P <sub>out</sub> = -14 dBm per carrier <sup>(3)</sup>	-66		1	
ACPR		1 WCDMA signal; P <sub>out</sub> = -8 dBm <sup>(2)</sup>	-80			
	Manager about a la company of	1 WCDMA signal; P <sub>out</sub> = -8 dBm <sup>(3)</sup>	-78		JD -	
A	Alternate-channel power ratio	2 WCDMA signal; P <sub>out</sub> = -11 dBm <sup>(3)</sup>	-74		dBc	
		4 WCDMA signals; P <sub>out</sub> = -14 dBm per carrier <sup>(3)</sup>	-68			

<sup>(1)</sup> The contribution from the source of about 0.28% is not de-embedded from the measurement.

<sup>(2)</sup> Measured with DAC5687 as source generator; with 2.5 MHz LPF.

<sup>(3)</sup> Measured with DAC5687 as source generator; no external BB filters are used.

**NSTRUMENTS** 



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#### **RF OUTPUT PARAMETERS (continued)**

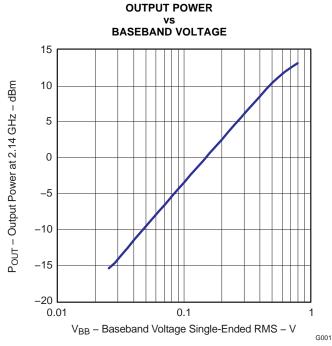
over recommended operating conditions, power supply = 5 V,  $T_A = 25$ °C,  $V_{CM} = 1.7$  V,  $V_{inBB} = 98$  mVrms single-ended in quadrature,  $f_{BB} = 50 \text{ kHz}$  (unless otherwise noted)

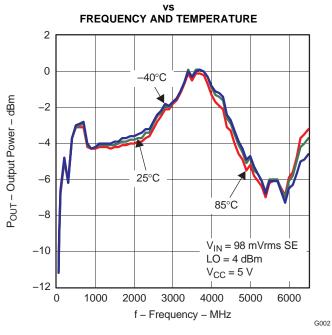
	PARAMETER	TEST CONDITIONS	MIN TYP MAX	UNIT
f <sub>LO</sub> = 2	500 MHz at 8 dBm			
G	Voltage gain	Output rms voltage over input I (or Q) rms voltage	-1.6	dB
P1dB	Output compression point		13	dBm
IP3	Output IP3	$f_{BB} = 4.5$ , 5.5 MHz; $P_{out} = -8$ dBm per tone	29	dBm
IP2	Output IP2	$f_{BB} = 4.5$ , 5.5 MHz; $P_{out} = -8$ dBm per tone	65	dBm
	Carrier feedthrough	Unadjusted	<del>-</del> 37	dBm
	Sideband suppression	Unadjusted; f <sub>BB</sub> = 4.5, 5.5 MHz	-47	dBc
<b>5</b> \ <b>() 4</b>	<b>F</b>	WiMAX 5-MHz carrier, P <sub>out</sub> = -8 dBm <sup>(4)</sup>	<b>–47</b>	dB
EVM	Error vector magnitude (rms)	WiMAX 5-MHz carrier, P <sub>out</sub> = 0 dBm <sup>(4)</sup>	-45	dB
f <sub>LO</sub> = 3	500 MHz at 8 dBm			!
G	Voltage gain	Output rms voltage over input I (or Q) rms voltage	0.6	dB
P1dB	Output compression point		13.5	dBm
IP3	Output IP3	f <sub>BB</sub> = 4.5, 5.5 MHz	25	dBm
IP2	Output IP2	f <sub>BB</sub> = 4.5, 5.5 MHz	65	dBm
	Carrier feedthrough	Unadjusted	<del>-</del> 35	dBm
	Sideband suppression	Unadjusted; f <sub>BB</sub> = 4.5, 5.5 MHz	-36	dBc
E) // /	<b>F</b>	WiMAX 5-MHz carrier, P <sub>out</sub> = -8 dBm <sup>(4)</sup>	-47	dB
EVM	Error vector magnitude (rms)	WiMAX 5-MHz carrier, P <sub>out</sub> = 0 dBm <sup>(4)</sup>	-43	dB
f <sub>LO</sub> = 4	000 MHz at 8 dBm			
G	Voltage gain	Output rms voltage over input I (or Q) rms voltage	0.2	dB
P1dB	Output compression point		12	dBm
IP3	Output IP3	f <sub>BB</sub> = 4.5, 5.5 MHz	22.5	dBm
IP2	Output IP2	f <sub>BB</sub> = 4.5, 5.5 MHz	60	dBm
	Carrier feedthrough	Unadjusted	-36	dBm
	Sideband suppression	Unadjusted; f <sub>BB</sub> = 4.5, 5.5 MHz	-36	dBc
f <sub>LO</sub> = 5	800 MHz at 4 dBm			•
G	Voltage gain	Output rms voltage over input I (or Q) rms voltage	-5.5	dB
P1dB	Output compression point		12.9	dBm
IP3	Output IP3	f <sub>BB</sub> = 4.5, 5.5 MHz	25	dBm
IP2	Output IP2	f <sub>BB</sub> = 4.5, 5.5 MHz	55	dBm
	Carrier feedthrough	Unadjusted	-31	dBm
	Sideband suppression	Unadjusted; f <sub>BB</sub> = 4.5, 5.5 MHz	-36	dBc
EVM	Error-vector magnitude	WiMAX 5-MHz carrier, P <sub>out</sub> = -12 dBm <sup>(4)</sup>	-40	dB

<sup>(4)</sup> Sideband suppression optimized with LO drive level; EVM contribution from instrument is not accounted for.

#### TYPICAL CHARACTERISTICS

 $V_{CM} = 1.7 \text{ V}$ ,  $V_{inBB} = 98 \text{ mVrms}$  single-ended sine wave in quadrature,  $V_{CC} = 5 \text{ V}$ , LO power = 4 dBm (single-ended),  $f_{BB} = 50 \text{ kHz}$  (unless otherwise noted).





**OUTPUT POWER** 

Figure 1.

Figure 2.

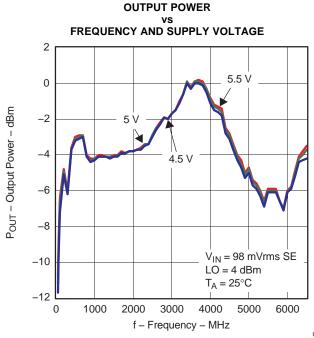
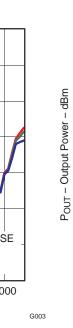


Figure 3.



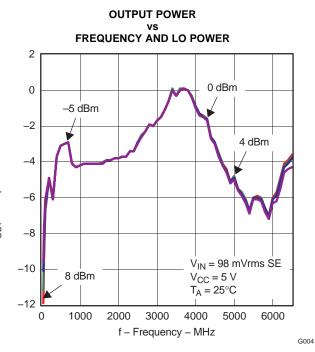


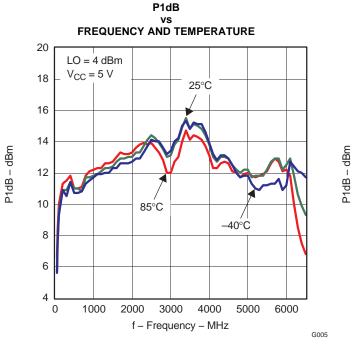
Figure 4.

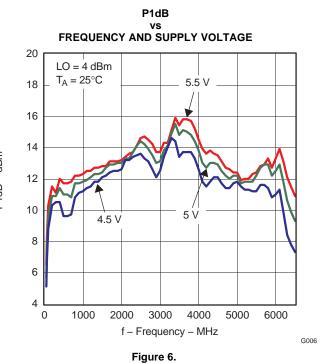
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# TYPICAL CHARACTERISTICS (continued)

 $V_{CM} = 1.7 \text{ V}$ ,  $V_{inBB} = 98 \text{ mVrms}$  single-ended sine wave in quadrature,  $V_{CC} = 5 \text{ V}$ , LO power = 4 dBm (single-ended),  $f_{BB} = 50 \text{ mV}$ kHz (unless otherwise noted).





**INSTRUMENTS** 

Figure 5.

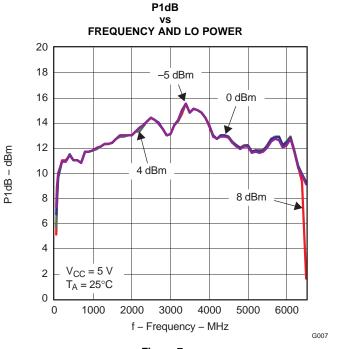


Figure 7.

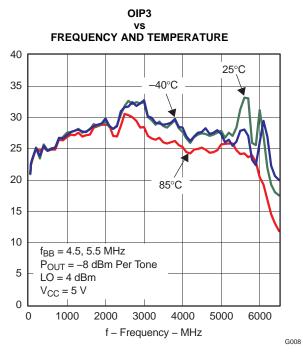


Figure 8.

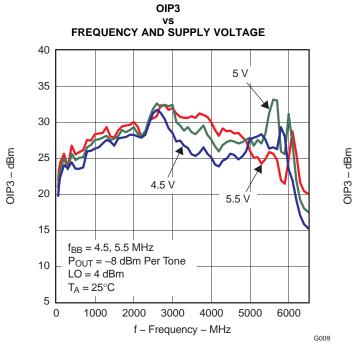
Submit Documentation Feedback

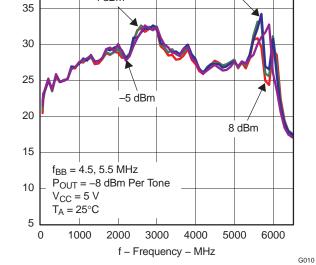
OIP3 - dBm

#### TYPICAL CHARACTERISTICS (continued)

 $V_{CM} = 1.7 \text{ V}$ ,  $V_{inBB} = 98 \text{ mVrms}$  single-ended sine wave in quadrature,  $V_{CC} = 5 \text{ V}$ , LO power = 4 dBm (single-ended),  $f_{BB} = 50 \text{ kHz}$  (unless otherwise noted).

40





OIP3

FREQUENCY AND LO POWER

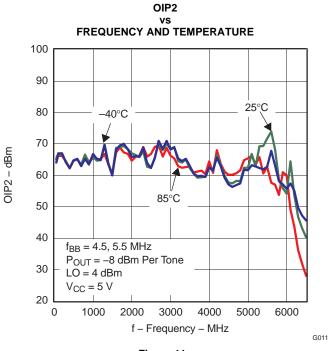
4 dBm

0 dBm

Figure 9.



OIP2



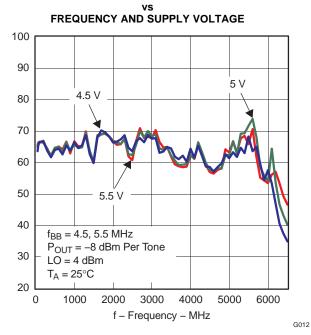


Figure 11.

Figure 12.

OIP2 - dBm



#### TYPICAL CHARACTERISTICS (continued)

2S - Unadjusted Carrier Feedthrough - dBm

0

-20

-30

-40

-50

-60

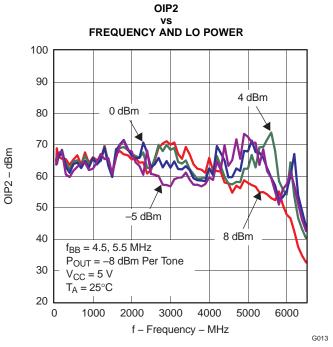
-70

-80

0

1000

 $V_{CM} = 1.7 \text{ V}$ ,  $V_{inBB} = 98 \text{ mVrms}$  single-ended sine wave in quadrature,  $V_{CC} = 5 \text{ V}$ , LO power = 4 dBm (single-ended),  $f_{BB} = 50 \text{ mV}$ kHz (unless otherwise noted).



# **UNADJUSTED CARRIER FEEDTHROUGH** FREQUENCY AND TEMPERATURE LO = 4 dBm $V_{CC} = 5 V$ -40°C

25°C

4000

5000

6000

G014

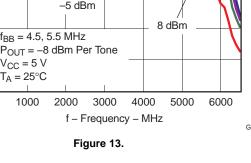
Figure 14.

85°C

3000

f - Frequency - MHz

2000





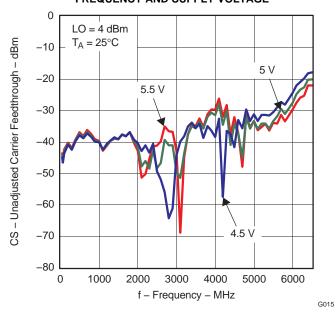


Figure 15.

# **UNADJUSTED CARRIER FEEDTHROUGH**

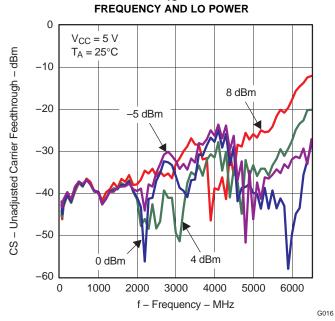


Figure 16.

#### TYPICAL CHARACTERISTICS (continued)

 $V_{CM} = 1.7 \text{ V}$ ,  $V_{inBB} = 98 \text{ mVrms}$  single-ended sine wave in quadrature,  $V_{CC} = 5 \text{ V}$ , LO power = 4 dBm (single-ended),  $f_{BB} = 50 \text{ kHz}$  (unless otherwise noted).

#### **UNADJUSTED SIDEBAND SUPPRESSION** FREQUENCY AND TEMPERATURE 0 SS - Unadjusted Sideband Suppression - dBc -10 -20 -40°C -3025°C -40 -50 -60 85°C -70 LO = 4 dBm $V_{CC} = 5 V$ -80 2000 3000 4000 6000 0 1000 5000 f - Frequency - MHz G017

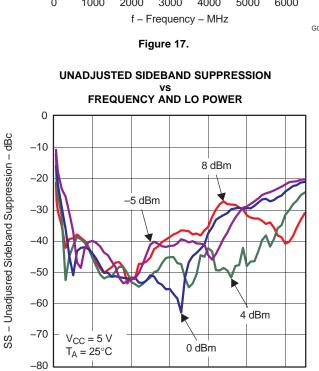


Figure 19.

3000

f - Frequency - MHz

4000

6000

G019

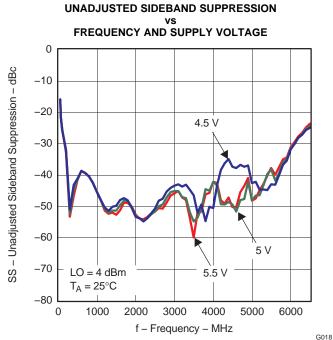


Figure 18.

# NOISE AT 13-MHz OFFSET (dBm/Hz) vs FREQUENCY AND TEMPERATURE

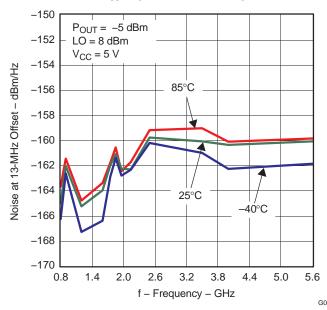


Figure 20.

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1000

2000



#### TYPICAL CHARACTERISTICS (continued)

 $V_{CM} = 1.7 \text{ V}$ ,  $V_{inBB} = 98 \text{ mVrms}$  single-ended sine wave in quadrature,  $V_{CC} = 5 \text{ V}$ , LO power = 4 dBm (single-ended),  $f_{BB} = 50 \text{ kHz}$  (unless otherwise noted).

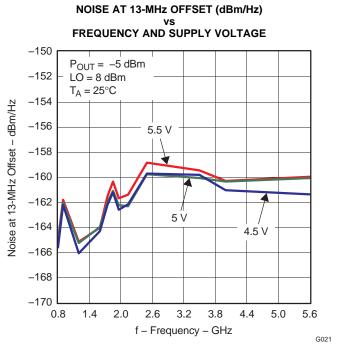


Figure 21.

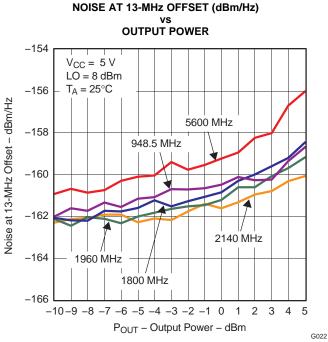


Figure 22.

# ADJUSTED CARRIER FEEDTHROUGH vs FREQUENCY AND TEMPERATURE

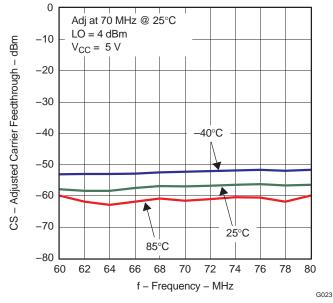


Figure 23.

#### ADJUSTED CARRIER FEEDTHROUGH vs FREQUENCY AND TEMPERATURE

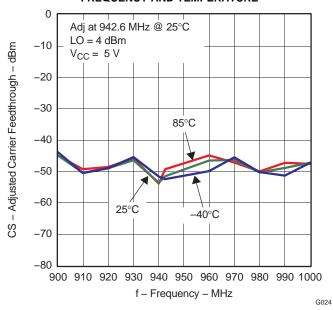


Figure 24.

#### TYPICAL CHARACTERISTICS (continued)

 $V_{CM} = 1.7 \text{ V}$ ,  $V_{inBB} = 98 \text{ mVrms}$  single-ended sine wave in quadrature,  $V_{CC} = 5 \text{ V}$ , LO power = 4 dBm (single-ended),  $f_{BB} = 50 \text{ kHz}$  (unless otherwise noted).

G025

#### **ADJUSTED CARRIER FEEDTHROUGH** FREQUENCY AND TEMPERATURE 0 Adj at 2140 MHz @ 25°C LO = 4 dBm-10 CS - Adjusted Carrier Feedthrough - dBm $V_{CC} = 5 V$ -20-40°C -3085°C -40 -50 -60 25°C -70 -80 2080 2120 2200 2240 2040 2160



f - Frequency - MHz

#### vs FREQUENCY AND TEMPERATURE 0 Adj at 2500 MHz @ 25°C LO = 4 dBm-10 CS - Adjusted Carrier Feedthrough - dBm $V_{CC} = 5 V$ -20–40°C -30-40 -50 -60 25°C -70 85°C -80 2400 2440 2480 2600 2520 2560 f - Frequency - MHz G026

**ADJUSTED CARRIER FEEDTHROUGH** 

Figure 26.

# ADJUSTED CARRIER FEEDTHROUGH vs FREQUENCY AND TEMPERATURE

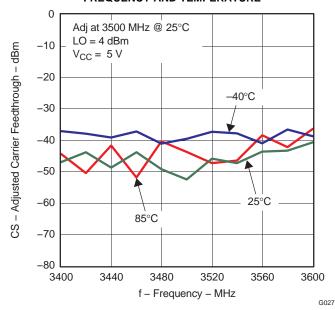


Figure 27.

#### ADJUSTED CARRIER FEEDTHROUGH vs FREQUENCY AND TEMPERATURE

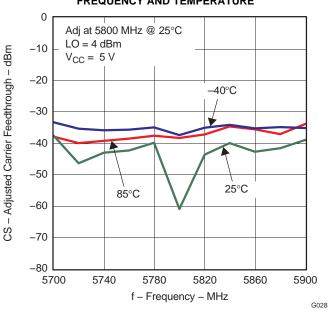


Figure 28.

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-80

60

62 64



#### TYPICAL CHARACTERISTICS (continued)

 $V_{CM} = 1.7 \text{ V}$ ,  $V_{inBB} = 98 \text{ mVrms}$  single-ended sine wave in quadrature,  $V_{CC} = 5 \text{ V}$ , LO power = 4 dBm (single-ended),  $f_{BB} = 50 \text{ kHz}$  (unless otherwise noted).

G029

### **ADJUSTED SIDEBAND SUPPRESSION** FREQUENCY AND TEMPERATURE 0 Adj at 70 MHz @ 25°C LO = 4 dBmSS - Adjusted Sideband Suppression - dBc -10 $V_{CC} = 5 V$ -20 -30-40 -50 85°C -60 25°C -40°C -70

## Figure 29.

f - Frequency - MHz

68 70 72 74 76

66

### FREQUENCY AND TEMPERATURE Adj at 942.6 MHz @ 25°C LO = 4 dBmSS - Adjusted Sideband Suppression - dBc $V_{CC} = 5 V$ -20-3025°C -40°C -40 -50 -6085°C -70 -80 900 910 920 930 940 950 960 970 980 990 1000

**ADJUSTED SIDEBAND SUPPRESSION** 

Figure 30.

f - Frequency - MHz



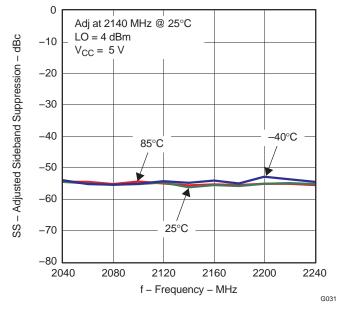


Figure 31.

# ADJUSTED SIDEBAND SUPPRESSION vs FREQUENCY AND TEMPERATURE

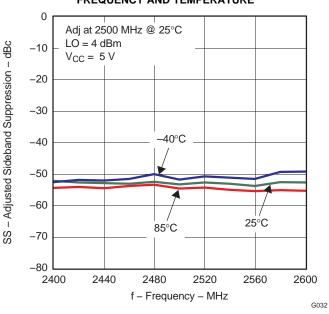


Figure 32.

#### TYPICAL CHARACTERISTICS (continued)

 $V_{CM} = 1.7 \text{ V}$ ,  $V_{inBB} = 98 \text{ mVrms}$  single-ended sine wave in quadrature,  $V_{CC} = 5 \text{ V}$ , LO power = 4 dBm (single-ended),  $f_{BB} = 50 \text{ kHz}$  (unless otherwise noted).

#### **ADJUSTED SIDEBAND SUPPRESSION** FREQUENCY AND TEMPERATURE 0 Adj at 3500 MHz @ 25°C LO = 4 dBmSS - Adjusted Sideband Suppression - dBc -10 $V_{CC} = 5 V$ -20 -30 -40°C -40 -50 -60 -70 85°C 25°C -80

Figure 33.

f - Frequency - MHz

3520

3560

3600

G033

3480

3440

3400

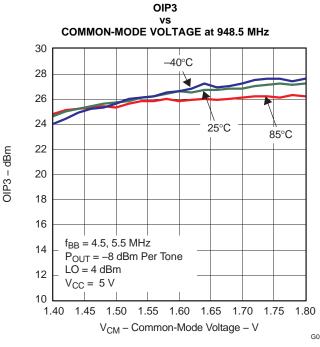


Figure 35.

# ADJUSTED SIDEBAND SUPPRESSION vs FREQUENCY AND TEMPERATURE

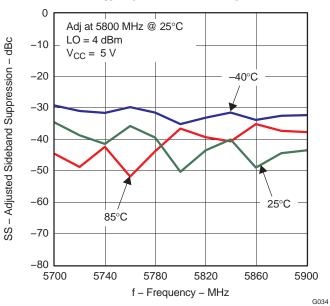


Figure 34.

#### OIP3 vs COMMON-MODE VOLTAGE at 1800 MHz

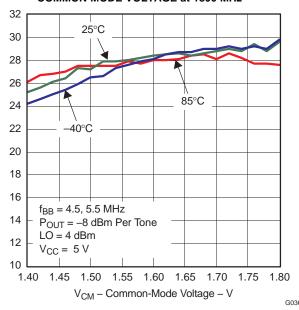


Figure 36.

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#### TYPICAL CHARACTERISTICS (continued)

 $V_{CM} = 1.7 \text{ V}$ ,  $V_{inBB} = 98 \text{ mVrms}$  single-ended sine wave in quadrature,  $V_{CC} = 5 \text{ V}$ , LO power = 4 dBm (single-ended),  $f_{BB} = 50 \text{ kHz}$  (unless otherwise noted).

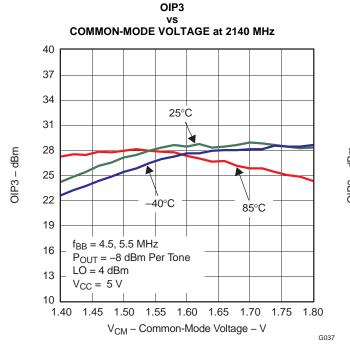


Figure 37.

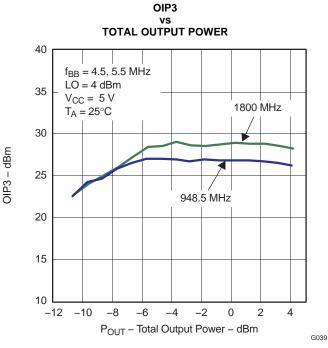


Figure 39.

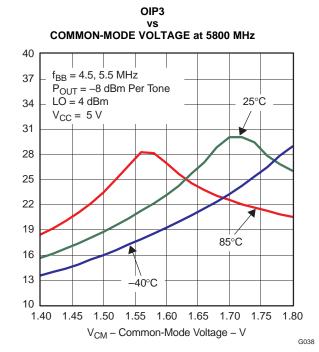


Figure 38.

# ADJACENT CHANNEL POWER RATIO vs OUTPUT POWER at 1960 MHz

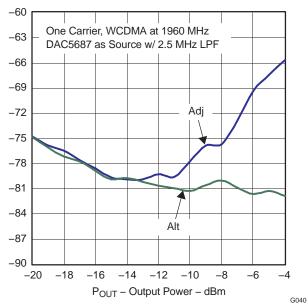


Figure 40.

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ACPR - Adjacent Channel Power Ratio - dBc



#### **TYPICAL CHARACTERISTICS (continued)**

 $V_{CM} = 1.7 \text{ V}$ ,  $V_{inBB} = 98 \text{ mVrms}$  single-ended sine wave in quadrature,  $V_{CC} = 5 \text{ V}$ , LO power = 4 dBm (single-ended),  $f_{BB} = 50 \text{ mV}$ kHz (unless otherwise noted).

Distribution – %

### **ADJACENT CHANNEL POWER RATIO**

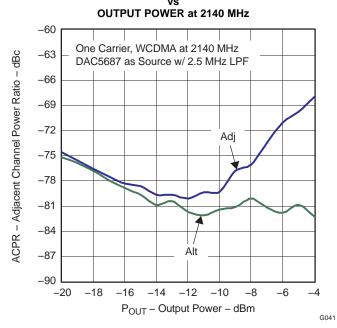


Figure 41.

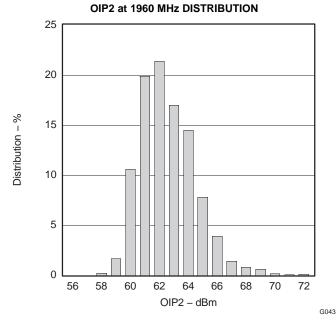


Figure 43.

#### **OIP3 at 1960 MHz DISTRIBUTION**

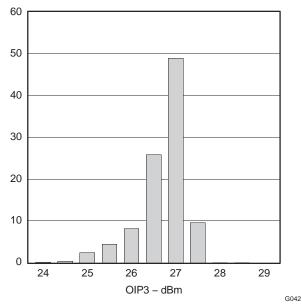


Figure 42.

#### **UNADJUSTED CARRIER FEEDTHROUGH** at 1960 MHz DISTRIBUTION

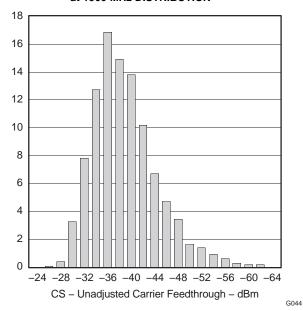


Figure 44.

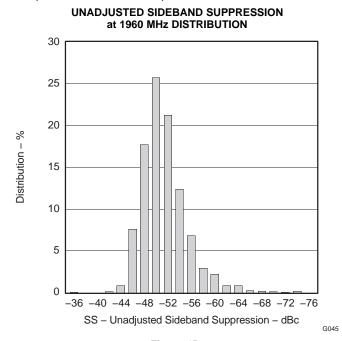
Distribution – %

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#### TEXAS INSTRUMENTS

#### TYPICAL CHARACTERISTICS (continued)

 $V_{CM} = 1.7 \text{ V}$ ,  $V_{inBB} = 98 \text{ mVrms}$  single-ended sine wave in quadrature,  $V_{CC} = 5 \text{ V}$ , LO power = 4 dBm (single-ended),  $f_{BB} = 50 \text{ kHz}$  (unless otherwise noted).



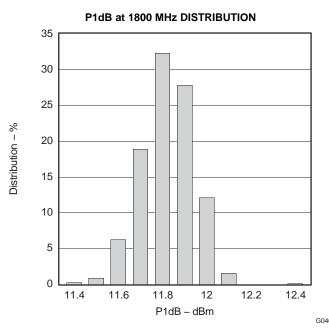


Figure 45.

Figure 46.

#### APPLICATION INFORMATION AND EVALUATION BOARD

#### **Basic Connections**

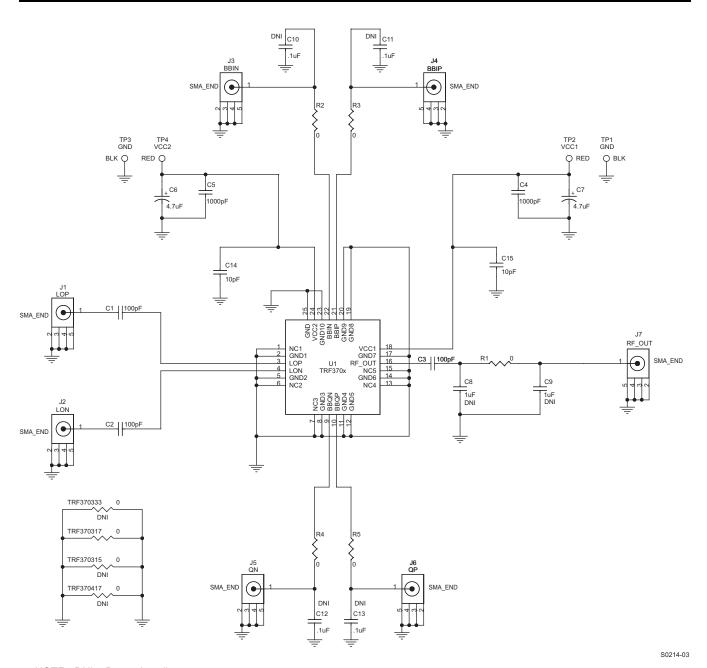
- See Figure 47 for proper connection of the TRF3704 modulator.
- Connect a single power supply (4.5 V–5.5 V) to pins 18 and 24. These pins should be decoupled as shown on pins 4, 5, 6, and 7.
- Connect pins 2, 5, 8, 11, 12, 14, 17, 19, 20, and 23 to GND.
- Connect a single-ended LO source of desired frequency to LOP (amplitude between -5 dBm and 12 dBm).
   This should be ac-coupled through a 100-pF capacitor.
- Terminate the ac-coupled LON with 50  $\Omega$  to GND.
- Connect a baseband signal to pins 21 = I, 22 = I, 10 = Q, and 9 = Q.
- The differential baseband inputs should be set to the proper common-mode voltage of 1.7V.
- RF\_OUT, pin 16, can be fed to a spectrum analyzer set to the desired frequency, LO ± baseband signal. This
  pin should also be ac-coupled through a 100-pF capacitor.
- · All NC pins can be left floating.

#### **ESD Sensitivity**

RF devices may be extremely sensitive to electrostatic discharge (ESD). To prevent damage from ESD, devices should be stored and handled in a way that prevents the build-up of electrostatic voltages that exceed the rated level. Rated ESD levels should also not be exceeded while the device is installed on a printed circuit board (PCB). Follow these guidelines for optimal ESD protection:

- Low ESD performance is not uncommon in RF ICs; see the *Absolute Maximum Ratings* table. Therefore, customers' ESD precautions should be consistent with these ratings.
- The device should be robust once assembled onto the PCB unless external inputs (connectors, etc.) directly
  connect the device pins to off-board circuits.





NOTE: DNI = Do not install.

Figure 47. TRF3704 EVM Schematic

Figure 48 shows the top view of the TRF3704 EVM board.

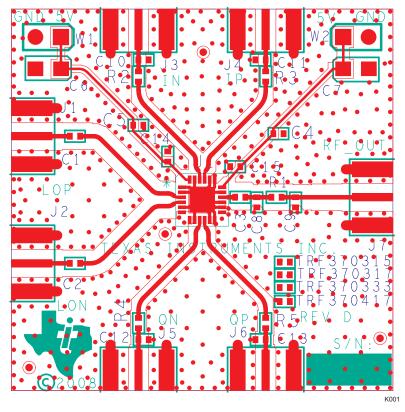


Figure 48. TRF3704 EVM Board Layout

Table 1. Bill of Materials for TRF370x EVM

Item Number	Quantity	Reference Designator	Value	PCB Footprint	Mfr. Name	Mfr. Part Number	Note
1	3	C1, C2, C3	100 pF	0402	PANASONIC	ECJ-0EC1H101J	
2	2	C4, C5	1000 pF	0402	PANASONIC	ECJ-0VC1H102J	
3	2	C6, C7	4.7 μF	TANT_A	KERMET	T491A475K016AS	
4	0	C8, C9	1 μF	0402	PANASONIC	ECJ- 0EC1H010C_DNI	DNI
5	0	C10, C11, C12, C13	0.1 μF	0402	PANASONIC	ECJ- 0EB1A104K_DNI	DNI
6	2	C14, C15	10 pF	0402	MURATA	GRM1555C1H100 JZ01D	
7	7	J1, J2, J3, J4, J5, J6, J7	LOP	SMA_SMEL_250x215	JOHNSON COMPONENTS	142-0711-821	
8	2	R1	0	0402	PANASONIC	ERJ-2GE0R00	OR EQUIVALENT
9	4	R2, R3, R4, R5	0	0402	PANASONIC	ERJ-2GE0R00	OR EQUIVALENT

Item Number	Quantity	Reference Designator	Value	PCB Footprint	Mfr. Name	Mfr. Part Number	Note
			TRF370333	QFN_24_163x163_ 0p50mm	ТІ	TRF370333	For TRF370333 EVM, TI supplied
10	4	U1	TRF370317	QFN_24_163x163_ 0p50mm	ТІ	TRF370317	For TRF370317 EVM, TI supplied
10	10 1	O1	TRF370315	QFN_24_163x163_ 0p50mm	ТІ	TRF370315	For TRF370315 EVM, TI supplied
			TRF370417	QFN_24_163x163_ 0p50mm	ТІ	TRF370417	For TRF370417 EVM, TI supplied
11	2	TP1, TP3	BLK	TP_THVT_100_RND	KEYSTONE	5001K	
12	2	TP2, TP4	RED	TP_THVT_100_RND	KEYSTONE	5000K	

#### **GSM Applications**

The TRF370417 is suited for GSM and multicarrier GSM applications because of its high linearity and low noise level over the entire recommended operating range. It also has excellent EVM performance, which makes it ideal for the stringent GSM/EDGE applications.

#### **WCDMA Applications**

The TRF370417 is also optimized for WCDMA applications where both adjacent-channel power ratio (ACPR) and noise density are critically important. Using Texas instruments' DAC568X series of high-performance digital-to-analog converters as depicted in Figure 49, excellent ACPR levels were measured with one-, two-, and four-WCDMA carriers. See *Electrical Characteristics*,  $f_{LO} = 1960$  MHz and  $f_{LO} = 2140$  MHz for exact ACPR values.

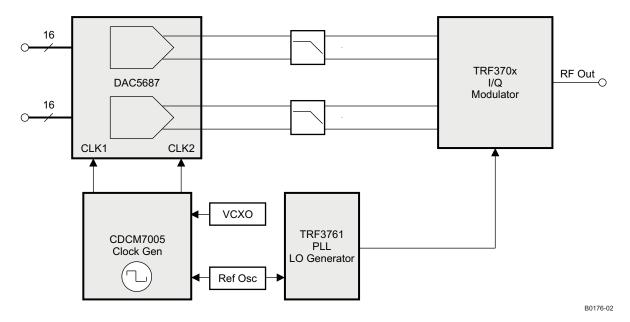


Figure 49. Typical Transmit Setup Block Diagram

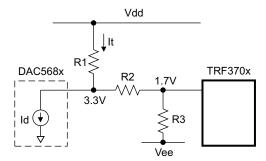
#### **DAC-to-Modulator Interface Network**

For optimum linearity and dynamic range, the digital-to-analog converter (DAC) can interface directly with the modulator; however, the common-mode voltage of each device must be maintained. A passive interface circuit is used to transform the common-mode voltage of the DAC to the desired set-point of the modulator. The passive circuit invariably introduces some insertion loss between the two devices. In general, it is desirable to keep the insertion loss as low as possible to achieve the best dynamic range. Figure 50 shows the passive interconnect

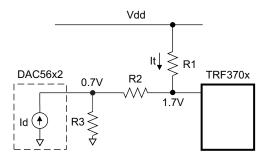
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circuit for two different topologies. One topology is used when the DAC (e.g., DAC568x) common mode is larger than the modulator. The voltage  $V_{ee}$  is nominally set to ground, but can be set to a negative voltage to reduce the insertion loss of the network. The second topology is used when the DAC (e.g., DAC56x2) common mode is smaller than the modulator. Note that this passive interconnect circuit is duplicated for each of the differential I/Q branches.



Topology 1: DAC Vcm > TRF370x Vcm



Topology 2: DAC Vcm < TRF370x Vcm

Figure 50. Passive DAC-to-Modulator Interface Network

Table 2. DAC-to-Modulator Interface Network Values

	Торо	logy 1	Tamalamı 2
	With Vee = 0 V	With Vee = −5 V	Topology 2
DAC Vcm [V]	3.3	3.3	0.7
TRF370x Vcm [V]	1.7	1.7	1.7
Vdd [V]	5	5	5
Vee [V]	Gnd	-5	N/A
R1 [Ω]	66	56	960
R2 [Ω]	100	80	290
R3 [Ω]	108	336	52
Insertion loss [dB]	5.8	1.9	2.3

#### **DEFINITION OF SPECIFICATIONS**

#### **Unadjusted Carrier Feedthrough**

This specification measures the amount by which the local oscillator component is suppressed in the output spectrum of the modulator. If the common mode voltage at each of the baseband inputs is exactly the same and there was no dc imbalance introduced by the modulator, the LO component would be naturally suppressed. DC offset imbalances in the device allow some of the LO component to feed through to the output. Because this phenomenon is independent of the RF output power and the injected LO input power, the parameter is expressed in absolute power, dBm.

#### Adjusted (Optimized) Carrier Feedthrough

This differs from the unadjusted suppression number in that the baseband input dc offsets are iteratively adjusted around their theoretical value of VCM to yield the maximum suppression of the LO component in the output spectrum. This is measured in dBm.

#### **Unadjusted Sideband Suppression**

This specification measures the amount by which the unwanted sideband of the input signal is suppressed in the output of the modulator, relative to the wanted sideband. If the amplitude and phase within the I and Q branch of the modulator were perfectly matched, the unwanted sideband (or image) would be naturally suppressed. Amplitude and phase imbalance in the I and Q branches results in the increase of the unwanted sideband. This parameter is measured in dBc relative to the desired sideband.

#### **Adjusted (Optimized) Sideband Suppression**

This differs from the unadjusted sideband suppression in that the gain and phase of the baseband inputs are iteratively adjusted around their theoretical values to maximize the amount of sideband suppression. This is measured in dBc.

#### **Suppressions Over Temperature**

This specification assumes that the user has gone though the optimization process for the suppression in question, and set the optimal settings for the I, Q inputs. This specification then measures the suppression when temperature conditions change after the initial calibration is done.

Figure 51 shows a simulated output and illustrates the respective definitions of various terms used in this data sheet.

Product Folder Link(s): TRF370417



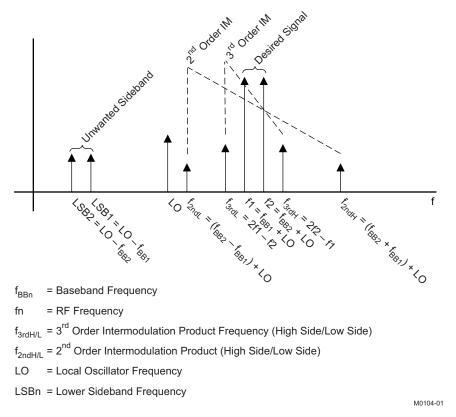


Figure 51. Graphical Illustration of Common Terms



#### PACKAGE OPTION ADDENDUM

11-Apr-2013

#### PACKAGING INFORMATION

Orderable Device	Status	Package Type	_	Pins		Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Top-Side Markings	Samples
	(1)		Drawing		Qty	(2)		(3)		(4)	
TRF370417IRGER	ACTIVE	VQFN	RGE	24	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	TRF37 0417	Samples
						& 110 SD/DI)				0417	
TRF370417IRGET	ACTIVE	VQFN	RGE	24	250	Green (RoHS	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	TRF37	Samples
						& no Sb/Br)				0417	battiples

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free** (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

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<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

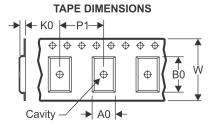
<sup>(4)</sup> Multiple Top-Side Markings will be inside parentheses. Only one Top-Side Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Top-Side Marking for that device.

### PACKAGE MATERIALS INFORMATION

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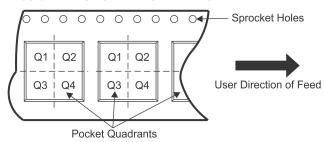
#### TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

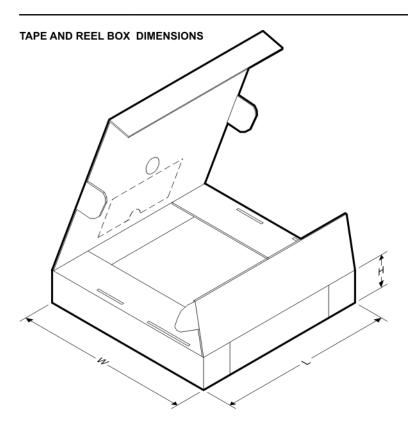
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

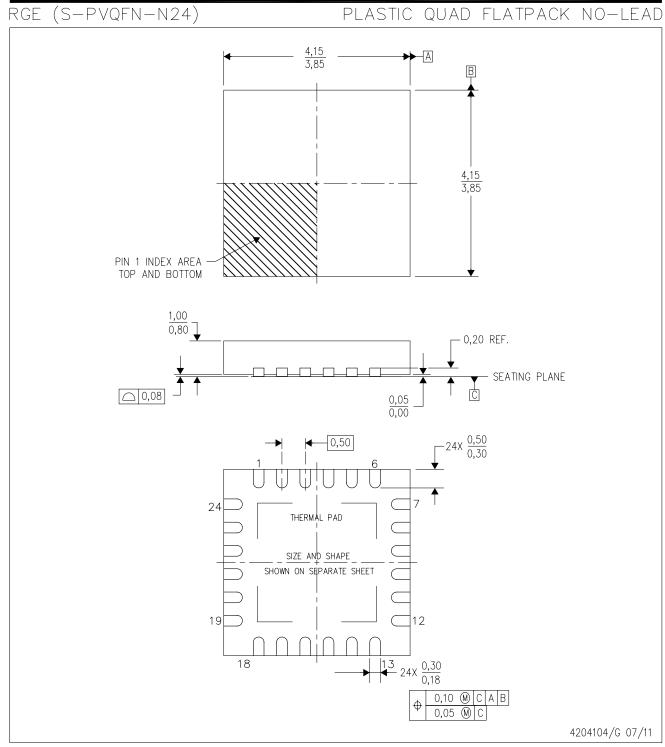
7 III dilitorio di Caro i i caro i i caro i i caro i i caro i car												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TRF370417IRGER	VQFN	RGE	24	3000	330.0	12.4	4.3	4.3	1.5	8.0	12.0	Q1
TRF370417IRGET	VQFN	RGE	24	250	180.0	12.4	4.3	4.3	1.5	8.0	12.0	Q1

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#### \*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)	
TRF370417IRGER	VQFN	RGE	24	3000	338.1	338.1	20.6	
TRF370417IRGET	VQFN	RGE	24	250	210.0	185.0	35.0	



NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M—1994.

- B. This drawing is subject to change without notice.
- C. Quad Flatpack, No-Leads (QFN) package configuration.
- D. The package thermal pad must be soldered to the board for thermal and mechanical performance.
- E. See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.
- F. Falls within JEDEC MO-220.



### RGE (S-PVQFN-N24)

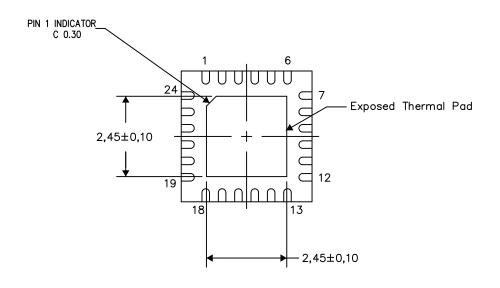
#### PLASTIC QUAD FLATPACK NO-LEAD

#### THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No—Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



Bottom View
Exposed Thermal Pad Dimensions

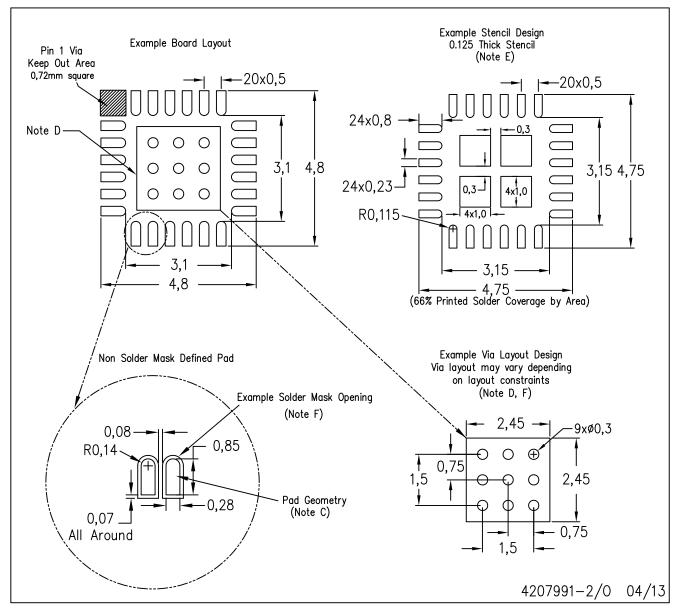
4206344-3/AC 03/13

NOTES: A. All linear dimensions are in millimeters



# RGE (S-PVQFN-N24)

### PLASTIC QUAD FLATPACK NO-LEAD



#### NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, Quad Flat—Pack Packages, Texas Instruments Literature No. <u>SLUA271</u>, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com <a href="http://www.ti.com">http://www.ti.com</a>.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
- F. Customers should contact their board fabrication site for recommended solder mask tolerances and via tenting recommendations for vias placed in the thermal pad.



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